



Agilent Technologies

Sample ID: Buist NaI CBZ conc HBr

Method Name: STUDENT ATR 32 4cm

Sample Scans: 32

User: STUDENT

Background Scans: 32

Date/Time: 18/09/2014 10:47:52

Resolution: 4 cm⁻¹

Range: 4,000.00 - 650.00

System Status: Good

Apodization: Happ-Genzel

File Location: C:\Program Files\Agilent\MicroLab PC\Results\STUDENT ATR 32 4cm\Buist NaI CBZ conc HBr_2014-09-18T10-48-59.a2r

